DUALSCOPE® MPOR DUALSCOPE® MPOR-FP

Pocket Instruments with PC-Interface for Convenient and Fast Coating Thickness Measurement on Virtually all Metals





DUALSCOPE® MPOR Models

Description			
	The DUALSCOPE MPOR and MPOR-FP measuring instruments measure coating thicknesses easily, quickly, non-destructively and with the precision that is typical for all Fischer instruments.		
Instrument properties	 Ideal for onsite applications due to the compact size, the light weight and the robust and durable instrument design 		
	 Intuitive operation of the menu navigation and graphic display. The display turns auto matically, like a smart phone 		
	 Second display for reading the measurement results directly on the top side of the instread Different languages are selectable 		
	 Manufacturer's certificate, included in the scope of supply 		
Generating measurements	The specimen's shape and permeability have a comparatively low influence on the measurement results Potential conductivity companies for measurements on non-magnetic substrate.		
	 Patented conductivity compensation for measurements on non-magnetic substrate materials 		
	 Two special measuring modes in accordance with the measurement regulations IMO PSPC (90/10-Rule) and SSPC-PA2 		
Applications	Steel or iron substrates (Fe)	Nonferrous metal substrates (NF)	
Examples	 Zinc, chromium, copper, paint, varnish and plastic coatings on steel, iron or cast 	 Paint, varnish or plastic coatings on aluminium, copper or brass 	
	iron (Fe)	Anodized coatings on aluminium	
	The instruments are applicable for measurements both on smooth and rough surfaces		
Models			
	 DUALSCOPE MPOR: Probe integrated in the measuring instrument for single-handed operation 		
	 DUALSCOPE MPOR-FP: Probe with cable (80 cm; 31.5 ") permanently connected to t instrument, for measurements on various specimen shapes 		
Evaluation			
Statistics	Display of mean value, standard deviation, MIN, MAX and number of measurements per block		
PC software	PC software FISCHER DataCenter with the following functionality: Transferring and		
included in the scope of supply	archiving measurement data, comprehensive statistical and graphical evaluations, easy creation and printing of inspection reports		
Measuring Modes			
Standard (Std)	Standard measuring mode for simple, universal coating thickness measurements, all measurement functions are available.		
IMO PSPC 90/10 (90.10)	90/10 rule stored in the instrument for coating thickness measurements according to the requirements of the "Performance Standard for Protective Coatings" of the International Maritime Organization (IMO PSPC).		
SSPC-PA2 (SSPC)	Coating thickness measurement according to the test specification SSPC-PA2 of the Society for Protective Coatings (SSPC).		

Measurement Functions

Block size Adjustable between 2 and 20 single readings per block

Tolerance limits Adjustable, depending on the selected measuring mode

Offset value In the standard mode, the freely adjustable offset value is deducted automatically from the

measured value. Thus, one obtains the thickness of the top coating if for instance the

interim coating is known.

Units of measurement Selectable µm or mils

Continuous display mode Measurement in "continuous display mode" for continuous sampling of the surfaces, e.g.,

in the manufacture of tanks and containers.

Normalization Adaptation to the substrate material and the shape of the specimen.

Factory calibration

Each individual instrument is factory calibrated at several reference points with the

greatest care to ensure the highest possible degree of trueness.

Corrective calibration (Adjustment)

Adaptation to the substrate material and the shape of the specimen and to a thickness

value using a calibration foil.

Simple Calibration

Adaption to the coating and substrate material in one step using a coated reference part with a coating thickness higher than 200 µm (7.87 inches). Nevertheless, this kind of calibration supplies only a lower accuracy as specified in the sections Trueness and Repeata-

bility Precision.

General Features

Calibration

Measuring method Magnetic induction method (ISO 2178, ASTM D7091, Measurement of non-magnetic

coatings on magnetic substrates);

Eddy current method (ISO 2360, ASTM D7091, Measurement of non-conductive coatings

on non-magnetic substrate metals);

Automatic selection of the measuring method corresponding to the substrate material

Probe tip radius: 2 mm (78 mils); Probe tip material: Hard metal

Data memory Max. 10,000 individual readings; the contents of the memory is retained even without

batteries

Measuring frequency More than 70 measurements per minute

Measurement acquisition Automatic upon placement of the probe; indication of the measurement with a beep

visually with a green lit LED

Display limit value violation Acoustically through 2 short beeps and visually with a red lit LED

Display

• Graphic display with an automatically turning display in order to read the measurement

results in many different instrument positions

• LCD display on the top side of the instrument, e.g., for reading the measurement value

for measuring overhead

Languages Many different display languages are selectable: German, English and several other

European and Asian languages

USB port 2.0 compatible, for connecting a PC

Data transfer Single readings, mean values, group separator

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DUALSCOPE® MPOR Models

Admissible ambient temperature

range during operation Weight (incl. batteries)

Power supply

MPOR: 137 g (4.8 oz); MPOR-FP: 184 g (6.5 oz)

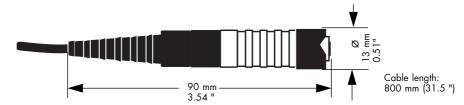
2 Batteries, LR6, AA, 1.5 V

Dimensions

Instrument Width: 64 mm (2.52 "); Depth: 28 mm (1.10 "); Height: 85 mm (3.35 ")

0 +40 °C (+32 ... +104 °F)

Probe of instrument MPOR-FP



Measurement Range	Steel or iron substrates (Fe)	Nonferrous metal substrates (NF)
	0 2000 μm (78 mils)	0 2000 μm (78 mils)
Trueness	Steel or iron substrates (Fe)	Nonferrous metal substrates (NF)
based on factory calibration stand- ards of the Helmut Fischer GmbH	0 75 μ m: $\leq 1.5 \mu$ m 75 1000 μ m: ≤ 2 % of reading 1000 2000 μ m: ≤ 3 % of reading 0 2.9 mils: ≤ 0.06 mils	$0 \dots 50 \ \mu m$: $\leq 1 \ \mu m$ $50 \dots 1000 \ \mu m$: $\leq 2 \%$ of reading $1000 \dots 2000 \ \mu m$: $\leq 3 \%$ of reading $0 \dots 2 \ mils$: $\leq 0.039 \ mils$
	 2.9 mils: ≤ 0.06 mils 2.9 39 mils: ≤ 2 % of reading 39 78 mils: ≤ 3 % of reading 	0 2 mils: ≤ 0.039 mils 2 39 mils: ≤ 2 % of reading 39 78 mils: ≤ 3 % of reading
Repeatability Precision	Steel or iron substrates (Fe)	Nonferrous metal substrates (NF)
based on factory calibration stand- ards of the Helmut Fischer GmbH, 5 single measurement readings on each standard	0 50 µm: ≤ 0.25 µm 50 2000 µm: ≤ 0.5 % of reading	0 100 μm: ≤ 0.5 μm 100 2000 μm: ≤ 0.5 % of reading
	0 2 mils: \leq 0.0098 mils 2 78 mils: \leq 0.5 % of reading	$0 \dots 3.9 \text{ mils}$: $\leq 0.0195 \text{ mils}$ $3.9 \dots 78 \text{ mils}$: $\leq 0.5 \% \text{ of reading}$
Ordering Data		

605-097 DUALSCOPE MPOR, probe integrated in the measuring instrument

605-114 DUALSCOPE MPOR-FP, probe with cable (80 cm; 31.5 ") permanently connected to the

instrument

Scope of Supply

Instrument case; protective instrument cover; lanyard; 2 batteries; metal plates NF/FE and ISO/NF for testing purposes; calibration foil (foil thickness about 75 µm (2.95 inches)); operator's manual; manufacturer's certificate; USB cable; support CD with USB drivers, software program FISCHER DataCenter for convenient evaluating, documenting and archiving of the measurement data, software program PC-Datex for exporting the measurement data to an Excel spreadsheet

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